

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/710,016	CHUANG ET AL.	
Examiner	Art Unit	
Gopal C. Ray	2111	

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SEARCHED					
Class	Subclass	Date	Examiner		
710	305,33,74, 1,315,316	12/29/2005	GCR		
709	228,230	12/29/2005	GCR		
709	250	12/29/2005	GCR		
711	149,100	12/29/2005	GCR		
711	145,211	12/29/2005	GCR		
713	1,100	12/29/2005	GCR		
704	7	12/29/2005	GCR		
365	63,189.08	12/29/2005	GCR		
365	230.03	12/29/2005	GCR		
365	230.05	12/29/2005	GCR		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
WEST: USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB (sse search history printouts)	12/29/2005	GCR			
EAST: USPT (sse search history printouts)	12/29/2005	GCR			
NPL: IEEE Xplore (sse search history printouts)	12/29/2005	GCR			
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